easyXAFS300+

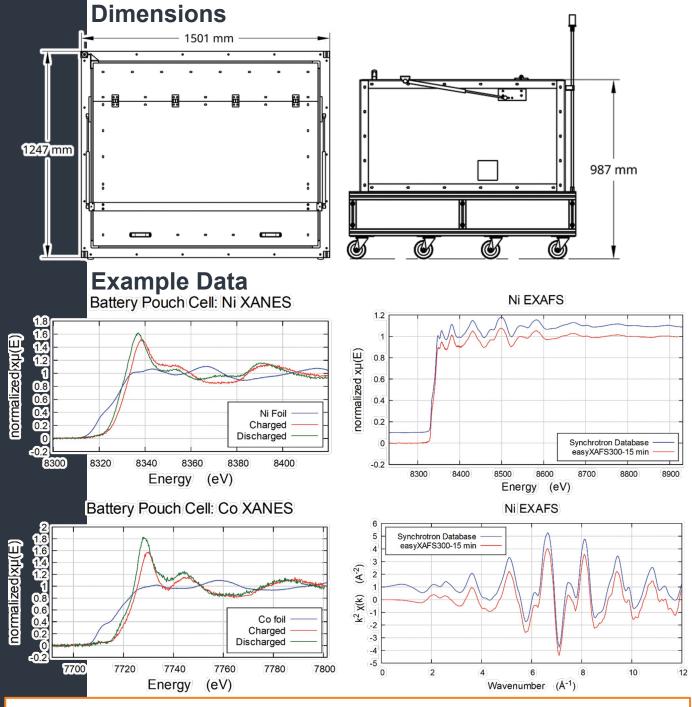


- Rapid transmission mode XAFS
- Proven research-quality performance
- High throughput for sample characterization or product testing
- Suitable for in situ R&D in electrical energy storage, catalysis, etc.
- Virtual beamline appearance with fully supported, easy to use software
- Run multiple samples or sample conditions with scripted operations
- Easy integration with ancillary equipment for control of sample conditions.
- Extremely low maintenance

PRODUCT SPECIFICATIONS

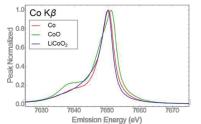
Energy Range	Standard operations from 5-12 keV*. Some utility up to 19 keV. *Depends on selection of crystal analyzers	Reproducibility	<50 meV energy scale drift with no monochromator realignment
Angular Range	55-85 degrees Bragg angle	Analyzer Crystals	Spherically-bent Si or Ge analyzers with 10-cm diameter and 50-cm radius of curvature
Resolving Power (E/ΔE)	typ. >5000, (i.e. 1.4 eV @ 7 keV) for Bragg ≥ 76 deg	Analyzer Alignment	Pre-aligned with "clock angle protocol" (pat. pend.) for rapid (~5 min) and reproducible swapping
Flux (XAFS)	Typical monochromatic flux of 300,000 - 500,000 photons/s when working near backscatter for 7-9 keV	Detector	Large-area SDD with 150-300 eV resolution for rejection of background and harmonics
Flux (XES)	Core-hole generation rate of ~10 ¹² /s for concentrated samples.	Sample Turret	7-position, motorized sample wheel available for programmable XAFS studies
X-Ray Source (XAFS)	1200-W XRD style, water-cooled tube with W/Mo or Ag anode. 40 kV maximum accelerating potential. 30 mA maximum filament current.	Software	LabVIEW-based GUI for calibration, regular operations, scripted scans and easy integration with external equipment. Python-based GUI for data processing for final spectra.
X-Ray Source (XES)	100-W XRF-style, air-cooled tube with W/Pd anode. 35 kV maximum accelerating potential. 4 mA maximum filament current.	Utility Requirements	 Helium gas for flight path 110-220 V/50-60 Hz, 1000-W for spectrometer drive and electronics 110-120 V/60 Hz OR 220-240 V/50 Hz, 1200-W water chiller 180-264 V/47-63 Hz, 1200-W for HV power supply 110-220 V/50-60 Hz, 300-W for control computer

easyXAFS300+



XES (high-resolution XRF)

Research-quality x-ray emission spectroscopy (XES) measurements in synchrotron-comparable integration times. Laboratory XES may facilitate insights into oxidation state, spin state, and ligand identity, even for very dilute samples.



easyXAFS300

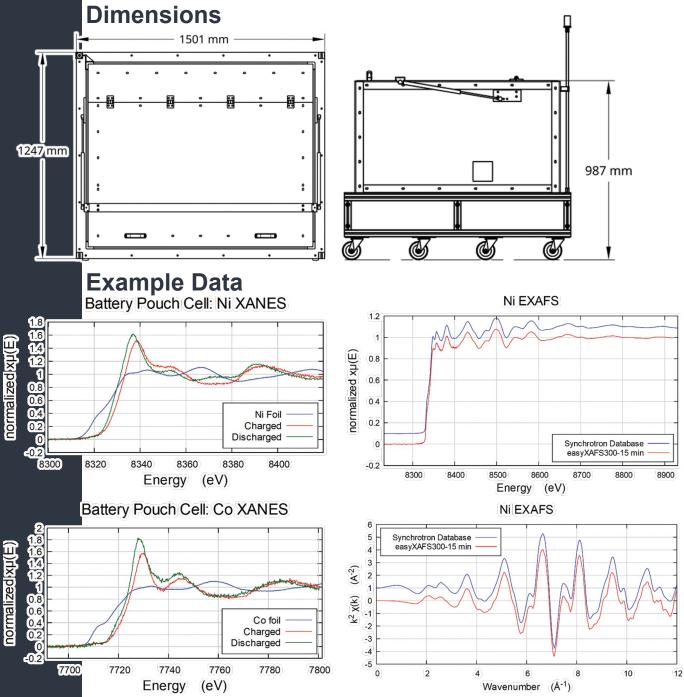


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PRODUCT SPECIFICATIONS

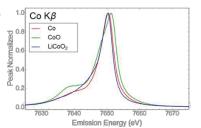
Energy Range	Standard operations from 5-12 keV*. Some utility up to 19 keV. *Depends on selection of crystal analyzers	Reproducibility	<50 meV energy scale drift with no monochromator realignment
Angular Range	55-85 degrees Bragg angle	Analyzer Crystals	Spherically-bent Si or Ge analyzers with 10-cm diameter and 50-cm radius of curvature
Resolving Power (Ε/ΔΕ)	typ. >5000, (i.e. 1.4 eV @ 7 keV) for Bragg ≥ 76 deg	Analyzer Alignment	Pre-aligned with "clock angle protocol" (pat. pend.) for rapid (~5 min) and reproducible swapping
Flux (XAFS)	Typical monochromatic flux of 300,000 - 500,000 photons/s when working near backscatter for 7-9 keV	Detector	Large-area SDD with 150-300 eV resolution for rejection of background and harmonics
Flux (XES)	XES capabilities available with easyXAFS300+ and easyXES150 systems	Sample Turret	7-position, motorized sample wheel available for programmable XAFS studies
X-Ray Source (XAFS)	1200-W XRD style, water-cooled tube with W/Mo or Ag anode. 40 kV maximum accelerating potential. 30 mA maximum filament current.	Software	LabVIEW-based GUI for calibration, regular operations, scripted scans and easy integration with external equipment. Python-based GUI for data processing for final spectra.
X-Ray Source (XES)	XES capabilities available with easyXAFS300+ and easyXES150 systems	Utility Requirements	 Helium gas for flight path 110-220 V/50-60 Hz, 1000-W for spectrometer drive and electronics 110-120 V/60 Hz OR 220-240 V/50 Hz, 1200-W water chiller 180-264 V/47-63 Hz, 1200-W for HV power supply 110-220 V/50-60 Hz, 300-W for control computer

easyXAFS300



XES (high-resolution XRF) Upgrade

The "easyXAFS300+" option adds on an auxiliary 100-W tube for research-quality x-ray emission spectroscopy (XES) measurements in synchrotron-comparable integration times. Laboratory XES may facilitate insights into oxidation state, spin state, and ligand identity, even for very dilute samples.



easyXES150

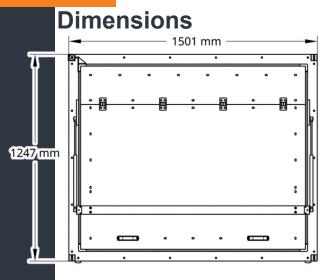


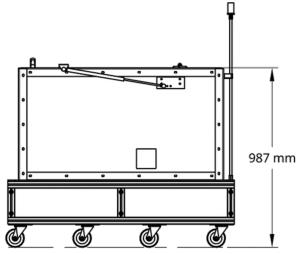
- Rapid transmission mode XAFS
- Proven research-quality performance
- High throughput for sample characterization or product testing
- Suitable for in situ R&D in electrical energy storage, catalysis, etc.
- Virtual beamline appearance with fully supported, easy to use software
- Run multiple samples or sample conditions with scripted operations
- Easy integration with ancillary equipment for control of sample conditions.
- Extremely low maintenance

PRODUCT SPECIFICATIONS

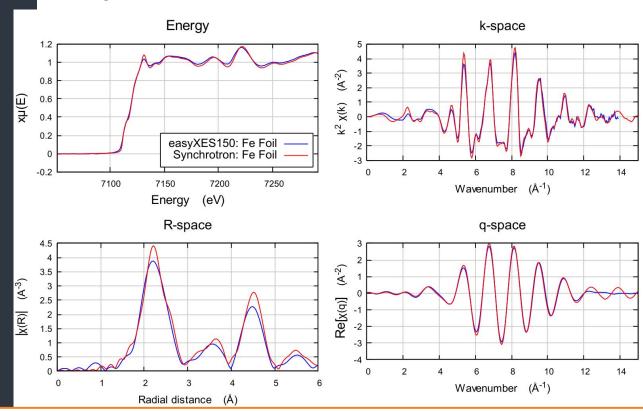
Energy Range	Standard operations from 4.5-12 keV*. Capabilities up to 19 keV with reduced throughput. *Depends on selection of crystal analyzers	Reproducibility	<50 meV energy scale drift with no monochromator realignment
Angular Range	55-85 degrees Bragg angle	Analyzer Crystals	Spherically-bent Si or Ge analyzers with 10-cm diameter and 50-cm radius of curvature
Resolving Power (E/ΔE)	typ. >2800 (i.e. 2.5 eV @ 7 keV) for Bragg ≥ 80deg	Analyzer Alignment	Pre-aligned with "clock angle protocol" (pat. pend.) for rapid (~5 min) and reproducible swapping
Flux (XAFS)	Typical monochromatic flux of >100,000/s when working near backscatter for 7-9 keV	Detector	Large-area SDD with 150-300 eV resolution for rejection of background and harmonics
Flux (XES)	Core-hole generation rate of ~10 ¹² /s for concentrated samples.	Sample Turret	7-position, motorized sample wheel available for programmable XAFS studies
X-Ray Source (XAFS)	100-W XRF-style, air-cooled tube with W/Pd anode. 35 kV maximum accelerating potential. 4 mA maximum filament current.	Software	· LabVIEW-based GUI for calibration, regular operations, scripted scans and easy integration with external equipment. Python-based GUI for data processing for final spectra.
X-Ray Source (XES)	100-W XRF-style, air-cooled tube with W/Pd anode. 35 kV maximum accelerating potential. 4 mA maximum filament current.	Utility Requirements	 Helium gas for flight-path 110-220 V/50-60 Hz, 1000-W for spectrometer drive and electronics 110-220 V/50-60 Hz, 300-W for control computer

easyXES150





Example Data - XAFS



XES (high-resolution XRF)

Research-quality x-ray emission spectroscopy (XES) measurements in synchrotron-comparable integration times. Laboratory XES may facilitate insights into oxidation state, spin state, and ligand identity, even for very dilute samples.

